IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:

Ki-hyun KIM et al.

Application No.: 10/765,278

5,278 ATTENTION

Confirmation No.: 7587 CERTIFICATE OF CORRECTION

Filed: January 28, 2004 BRANCH

U.S. Patent No.: 7,278,082

Issued: October 2, 2007

For: METHOD OF GENERATING PARITY DATA BASED ON LOW-DENSITY PARITY

CHECK MATRIX AND APPARATUS THEREFOR

REQUEST FOR CERTIFICATE OF CORRECTION

Commissioner for Patents PO Box 1450 Alexandria, VA 22313-1450

Sir:

Patentee(s) respectfully request(s) that a Certificate of Correction be issued in the subject patent, pursuant to 35 U.S.C. §254 and 37 C.F.R. §1.322, to correct the mistake(s) shown on the attached Certificate of Correction form.

Since the mistakes are Patent Office mistakes, it is believed that no fee is required.

Respectfully submitted,

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Date: 0 cf. 12, 2007

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UNITED STATES PATENT AND TRADEMARK OFFICE CERTIFICATE OF CORRECTION

PATENT NO: 7,278,082

DATED: October 2, 2007

INVENTOR(S): Ki-hyun KIM et al.

Title Page, Item (57) Abstract, line 2, change "panty" to --parity--.

Column 9, line 8, change "panty" to --parity--.

Column 9, line 32, delete "and".

Column 11, line 11, change "panty" to --parity--.

Column 12, line 20, change "panty" to --parity--.

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